

Ordering Information

Part Number	Package	Marking	Packing	Qty.
RS85N150T	T0-220	RS85N150T	Tube	50 PCS

Absolute Maximun Ratings Tc= 25° unless otherwise specified

Symbol	Parameter	RS85N150T	Units
VDSS	Drain-to-Source Voltage	85	V
ID	Continuous Drain Current TC=25 $^{\circ}$ C	150	
ID	Continuous Drain Current TC=100 $^\circ\!\!\mathbb{C}$	140	А
IDM	Pulsed Drain Current	600	
PD	Power Dissipation	310	W
VGS	Gate- to- Source Voltage	±20	V
EAS	Single Pulse Avalanche Engergy L = 0.5mH,IS = 55A, RG = 25Ω, Tj = 25℃	750	mJ
	Maximum Temperature for Soldering		
TL TPKG	Leads at 0.063in(1.6mm)from Case for 10 seconds Package Body for 10 seconds	300 260	°C
TJ and TSTG	Operating Junction and Storage Temperature Range	-55 to 150	

* Drain Current Limited by Maximum Junction Temperature

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" Table may cause permanent damage to the device.



Thermal Resistance

Symbol	Parameter	RS85N150T	Units	Test Conditions
RθJC	Junction-to-Case	0.4	°C/W	Drain lead soldered to water cooled heatsink, PD adjusted for a peak junction temperature of + 1 5 0 $^\circ\!\!C$
RθJA	Junction-to- Ambient	52		1 cubic foot chamber,free air.

OFF Characteristics TJ= 25° C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BVDSS	Drain- to- source Breakdown Voltage	85			V	VGS=0V,ID=250μ Α
IDSS	Drain- to- Source Leakage Current			1	μΑ	VDS=80V,VGS=0 V
	Gate- to- Source Forward Leakage			100	^	VGS=20V ,VDS=0 V
IGSS	Gate- to- Source Reverse Leakage			-100	nA	VGS=-20V ,VDS= 0V

ON Characteristics TJ=25°C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
RDS(on)	Static Drain- to- Source On- Resistance		2.8	3.6	mΩ	VGS=10V,ID=60A
VGS(TH)	Gate Threshold Voltage	2.0		4.0	V	VGS=VDS,ID=25 0μA

Resistive Switching Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
td(ON)	Turn- on Delay Time		37		- nS	VDS=43V ID=60A RG=4.7Ω VGS=10V
trise	Rise Time		63			
td(OFF)	Turn- OFF Delay Time		78			
tfall	Fall Time		41		1	



Dynamic Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Ciss	Input Capacitance		7447			VGS= 0V
Coss	Output Capacitance		1075		pF	VDS=43V
Crss	Reverse Transfer Capacitance		43			f=100KHz
Qg	Total Gate Charge		130			VDS= 68V
Qgs	Gate- to- Source Charge		40		nC	ID=60A
Qgd	Gate-to-Drain(" Miller") Charge		39			VGS=10V

Source- Drain Diode Characteristics

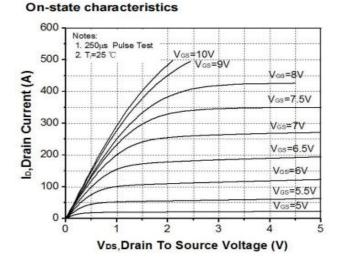
Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions	
IS	Continuous Source Current			150	А	Integral pn- diode	
ISM	Maximum Pulsed Current			600	Α	in MOSFET	
VSD	Diode Forward Voltage			1.4	V	IS=60A,VGS=0V	
trr	Reverse Recovery Time		56		nS	VGS=0V	
Qrr	Reverse Recovery Charge		84		nC	IS=60A di/dt=100A/μs	

Notes:

- * 1. Repetitive rating, pulse width limited by maximum junction temperature.
- * 2. Pulse Test: Pulse width \leq 300µs, Duty Cycle \leq 1.5%

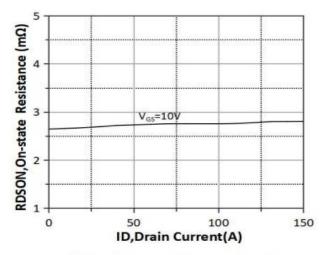


Typical Feature Curve

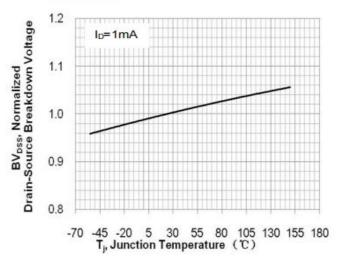


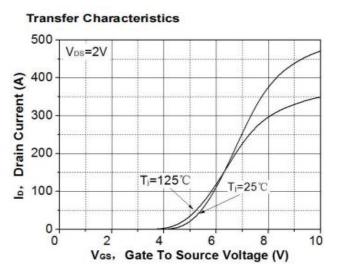
On-resistance variation vs.drain

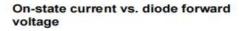
current and gate voltage

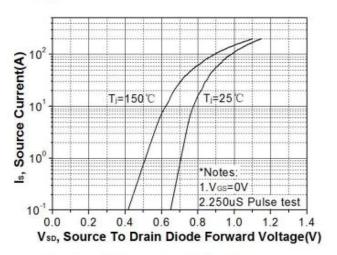


Breakdown voltage variation vs. junction temperature

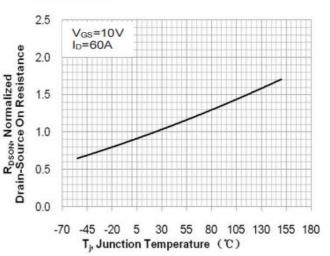








On-resistance variation vs. junction temperature

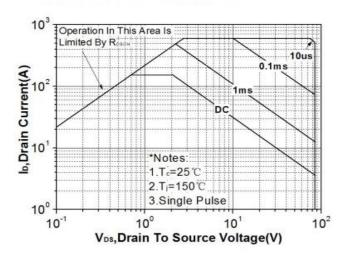


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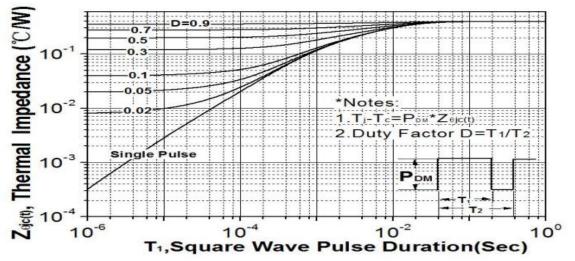


Gate charge characteristics

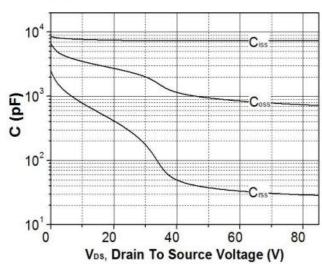
Maximum safe operating area



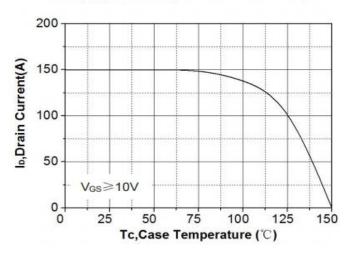
Transient thermal response curve



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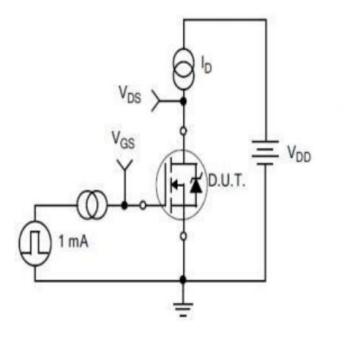


Maximum drain current vs. case temperature





Test ircuits and Waveforms



VGS(TH)

VDS

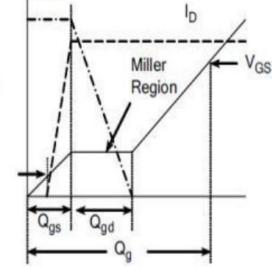


Figure A. Gate Charge Test Circuit

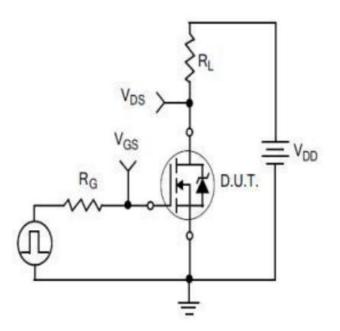


Figure C. Resistive Switching Test Circuit

Figure B. Gate Charge Waveform

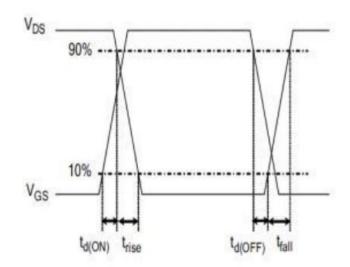
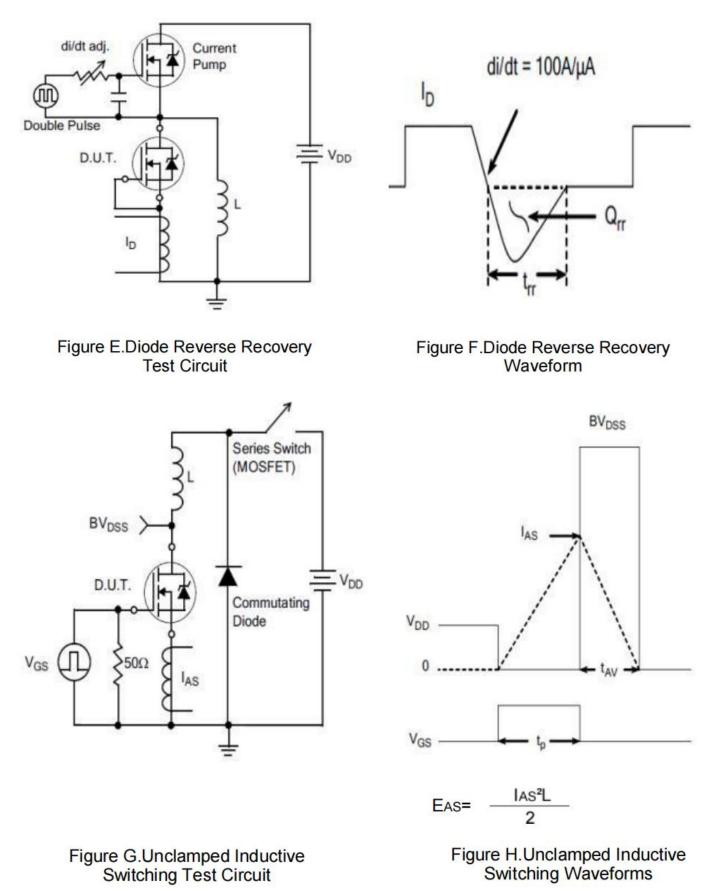


Figure D. Resistive Switching Waveforms

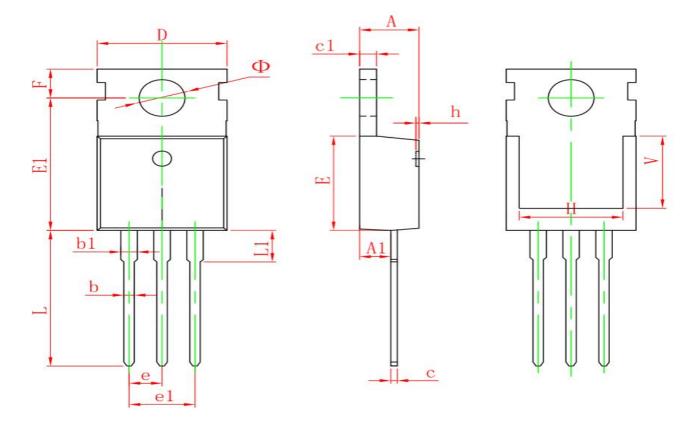


Test ircuits and Waveforms





Package outline drawing(TO-220 Unit: mm)



Symbol	Dimensions	In Millimeters	Dimension	s in inches	
Symbol	Min.	Max.	Min.	Max.	
A	4.400	4.600	0.173	0.181	
A1	2.250	2.550	0.089	0.100	
b	0.710	0.910	0.028	0.036	
b1	1.170	1.370	0.046	0.054	
С	0.330	0.650	0.013	0.026	
c1	1.200	1.400	0.047	0.055	
D	9.910	10.250	0.390	0.404	
E	8.950	9.750	0.352	0.384	
E1	12.650	13.050	0.498	0.514	
е	2.540	TYP.	0.100	TYP.	
e1	4.980	5.180	0.196	0.204	
F	2.650	2.950	0.104	0.116	
Н	7.900	8.100	0.311	0.319	
h	0.000	0.300	0.000	0.012	
L	12.900	13.400	0.508	0.528	
L1	2.850	3.250	0.112	0.128	
V	6.900	REF.	0.276 REF.		
Φ	3.400	3.800	0.134	0.150	



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